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PATENT & TRADEMARK OFFICE

INFORMATION DISCLOSURE CITATION

OMB No. 0651-0011

Atty. Docket No.	9090.0003-03	Appln. No.	09/821,170
Applicant	Dan Martin Scott et al.		
Filing Date	March 29, 2001	Group:	2671

U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
S.L.	4,737,916	04/12/88	Ogawa et al.	364	443	
S.L.	6,321,158	11/20/01	DeLorme et al.	701	201	
S.W.	6,377,278	04/23/02	Curtright et al.	345	634	
S.U.	6,084,989	07/04/00	Eppler	382	293	
S.W.	5,247,356	09/21/93	Ciampa	358	109	
S.L.	5,884,216	03/16/99	Shah et al.	701	207	
S.U.	5,699,244	12/16/97	Clark, Jr. et al.	364	420	
S.L.	5,848,373	12/08/98	DeLorme et al.	701	200	
S.U.	5,422,989	06/06/95	Bell et al.	395	133	
S.W.	5,592,375	01/07/97	Salmon et al.	395	207	
S.L.	5,467,271	11/14/95	Abel et al.	364	420	
S.L.	5,842,148	11/24/98	Prendergast et al.	702	34	
S.L.	4,885,706	12/05/89	Pate et al.	364	551.01	
S.L.	5,414,462	05/09/95	Veatch	348	135	

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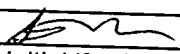
Technology Center 2600

FOREIGN PATENT DOCUMENTS

	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
S.L.	WO 97/49027	12/24/97	Europe			
S.U.	EP 0 619 554 A2	10/12/94	Europe			
S.W.	EP 0 454 129 A2	10/30/91	Europe			
S.W.	WO 90/14627	11/29/90	Europe			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

S.W.	Li et al., "Accuracy Assessment of Mapping Products Produced from the Star-3i Airborne IFSAR System".
S.W.	Fukunaga et al., "Image Registration Using an Image Graph and its Application to Map Matching," IEE Proceedings-E, Vol. 138, No. 2, March 1991
S.L.	Wang, "Integrating GIS's and Remote Sensing Image Analysis Systems by Unifying Knowledge Representation Schemes," IEEE Transactions on Geoscience and Remote Sensing, Vol. 29, No. 4, p. 656-664, July 1991
S.L.	Roux, "Automatic Registration of Spot Images and Digitized Maps," IEEE, p. 625-628, 1996

Examiner		Date Considered	05/15/03
*Examiner:	Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

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